

**Notice of References Cited**

Application/Control No.

09/725,674

Applicant(s)/Patent Under  
Reexamination  
HIRANO ET AL.

Examiner

Minh Dieu Nguyen

Art Unit

2137

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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